

N-channel TrenchMOS logic level FET Rev. 2 — 7 February 2011

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- AEC Q101 compliant
- Low conduction losses due to low on-state resistance
- Suitable for logic level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

Motors, lamps and solenoids

1.3 Applications

- 12 V loads
- Automotive and general purpose power switching

1.4 Quick reference data

Table 1 Quick reference data

QUICK reference	uata					
Parameter	Conditions		Min	Тур	Max	Unit
drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	40	V
drain current	V _{GS} = 5 V; T _{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>	<u>[1]</u>	-	-	75	A
total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	300	W
aracteristics						
oson drain-source on-state	V _{GS} = 4.3 V; I _D = 25 A; T _j = 25 °C		-	3.7	5.9	mΩ
resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C		-	2.9	4	mΩ
	$\label{eq:VGS} \begin{array}{l} V_{GS} = 5 \text{ V}; \text{ I}_{D} = 25 \text{ A}; \\ T_{j} = 25 \text{ °C}; \text{ see } \underline{\text{Figure 11}}; \\ \text{see } \underline{\text{Figure 12}} \end{array}$		-	3.5	4.4	mΩ
	Parameter drain-source voltage drain current total power dissipation aracteristics drain-source	$\begin{array}{ll} \mbox{drain-source} & T_j \geq 25 \ ^{\circ}\text{C}; \ T_j \leq 175 \ ^{\circ}\text{C} \\ \mbox{voltage} & \\ \mbox{drain current} & V_{GS} = 5 \ ^{\vee}\text{V}; \ T_{mb} = 25 \ ^{\circ}\text{C}; \\ \mbox{see Figure 1}; \ \mbox{see Figure 3} \\ \mbox{total power} & \\ \mbox{drain-source} & \\ \mbox{drain-source} & \\ \mbox{drain-source} & \\ \mbox{on-state} & \\ \mbox{resistance} & \\ \mbox{V}_{GS} = 4.3 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{C}; \\ \mbox{V}_{GS} = 10 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{C}; \\ \\ \mbox{V}_{GS} = 5 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{C}; \\ \mbox{V}_{GS} = 5 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{C}; \\ \\ \mbox{V}_{GS} = 5 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{C}; \\ \\ \mbox{V}_{GS} = 5 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{C}; \\ \\ \mbox{V}_{GS} = 5 \ ^{\vee}\text{V}; \ ^{\vee}\text{l}_\text{D} = 25 \ ^{\vee}\text{A}; \\ \\ \mbox{T}_{j} = 25 \ ^{\circ}\text{C}; \ \text{see Figure 11}; \\ \end{array}$	ParameterConditionsdrain-source voltage $T_j \ge 25 \ ^\circ C; \ T_j \le 175 \ ^\circ C$ drain current $V_{GS} = 5 \ V; \ T_{mb} = 25 \ ^\circ C; \ see \ Figure 3$ total power dissipation $T_{mb} = 25 \ ^\circ C; \ see \ Figure 2$ total power dissipation $T_{mb} = 25 \ ^\circ C; \ see \ Figure 2$ drain-source on-state resistance $V_{GS} = 4.3 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ C$ $V_{GS} = 10 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ C$ $V_{GS} = 5 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ C$ $V_{GS} = 5 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ C$ $V_{GS} = 5 \ V; \ I_D = 25 \ A; \ T_j = 25 \ ^\circ C$	$\begin{tabular}{ c c c c } \hline Parameter & Conditions & Min \\ \hline drain-source & T_j \ge 25 \ ^\circ C; \ T_j \le 175 \ ^\circ C & - \\ \hline voltage & & & & \\ \hline drain current & V_{GS} = 5 \ ^\vee; \ T_{mb} = 25 \ ^\circ C; & & & & \\ \hline drain current & V_{GS} = 5 \ ^\vee; \ T_{mb} = 25 \ ^\circ C; & & & \\ \hline total power & & & \\ \hline T_{mb} = 25 \ ^\circ C; \ see \ Figure \ 2 & - \\ \hline drain-source & & & \\ \hline drain-source & & & \\ \hline drain-source & & & \\ \hline v_{GS} = 4.3 \ V; \ I_D = 25 \ A; & - \\ \hline T_j = 25 \ ^\circ C & & \\ \hline v_{GS} = 10 \ V; \ I_D = 25 \ A; & - \\ \hline T_j = 25 \ ^\circ C & & \\ \hline v_{GS} = 5 \ V; \ I_D = 25 \ A; & - \\ \hline T_j = 25 \ ^\circ C; \ see \ Figure \ 11; & \\ \hline \end{tabular}$	$\begin{tabular}{ c c c c } \hline Parameter & Conditions & Min & Typ \\ \hline drain-source & T_j \ge 25 \ ^\circ C; \ T_j \le 175 \ ^\circ C & - & - \\ \hline voltage & V_{GS} = 5 \ V; \ T_{mb} = 25 \ ^\circ C; & [1] & - & - \\ \hline see \ Figure 1; \ see \ Figure 3 & & & & & \\ \hline total \ power & T_{mb} = 25 \ ^\circ C; \ see \ Figure 2 & - & - \\ \hline total \ power & T_{mb} = 25 \ ^\circ C; \ see \ Figure 2 & - & - \\ \hline aracteristics & & & & \\ \hline aracteristics & & & & \\ \hline drain-source & V_{GS} = 4.3 \ V; \ I_D = 25 \ A; & - & 3.7 \\ \hline T_j = 25 \ ^\circ C & & & & \\ \hline V_{GS} = 10 \ V; \ I_D = 25 \ A; & - & & 2.9 \\ \hline T_j = 25 \ ^\circ C & & & & \\ \hline V_{GS} = 5 \ V; \ I_D = 25 \ A; & - & & & 3.5 \\ \hline T_j = 25 \ ^\circ C; \ see \ Figure 11; & & & & \\ \hline \end{array}$	$\begin{tabular}{ c c c c } \hline Parameter & Conditions & Min & Typ & Max \\ \hline drain-source & T_j \ge 25 \ ^{\circ}C; \ T_j \le 175 \ ^{\circ}C & - & - & 40 \\ \hline drain current & V_{GS} = 5 \ V; \ T_{mb} = 25 \ ^{\circ}C; & 11 \ - & - & 75 \\ \hline see \ Figure 1; \ see \ Figure 3 & 1 \ - & - & 75 \\ \hline total power & T_{mb} = 25 \ ^{\circ}C; \ see \ Figure 2 & - & - & 300 \\ \hline aracteristics & & & & & & & & \\ \hline drain-source & & V_{GS} = 4.3 \ V; \ I_D = 25 \ A; & - & 3.7 \ 5.9 \\ \hline resistance & & & & & & & & & \\ \hline V_{GS} = 10 \ V; \ I_D = 25 \ A; & - & 2.9 \ 4 \\ \hline V_{GS} = 5 \ V; \ I_D = 25 \ A; & - & & & & & & & & \\ \hline V_{GS} = 5 \ V; \ I_D = 25 \ A; & - & & & & & & & & & \\ \hline V_{GS} = 5 \ V; \ I_D = 25 \ A; & - & & & & & & & & & & & & \\ \hline V_{GS} = 5 \ V; \ I_D = 25 \ A; & - & & & & & & & & & & & & \\ \hline V_{GS} = 5 \ V; \ I_D = 25 \ A; & - & & & & & & & & & & & & & & & & & $



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Table 1.	Quick reference da	tacontinued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 75 \text{ A}; V_{sup} \leq 40 \text{ V}; \\ R_{GS} &= 50 \Omega; V_{GS} = 5 \text{ V}; \\ T_{j(init)} &= 25 ^\circ\text{C}; \text{unclamped} \end{split}$	-	-	1.6	J
Dynamic	characteristics					
Q _{GD}	gate-drain charge	$V_{GS} = 5 V; I_D = 25 A;$ $V_{DS} = 32 V; T_j = 25 °C;$ see Figure 13	-	56	-	nC

[1] Continuous current is limited by package.

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		5
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

SOT78A (TO-220AB)

3. Ordering information

Table 3.	Orderina	information
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Type number	Package		
	Name	Description	Version
BUK9504-40A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A

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4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	40	V
V _{DGR}	drain-gate voltage	R_{GS} = 20 k Ω		-	40	V
V _{GS}	gate-source voltage			-15	15	V
I _D	drain current	T _{mb} = 100 °C; V _{GS} = 5 V; see <u>Figure 1</u>	[1]	-	75	А
		$T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } Figure 1; \text{ see } Figure 3$	[1]	-	75	А
			[2]	-	198	А
I _{DM}	peak drain current	T _{mb} = 25 °C; pulsed; t _p ≤ 10 μs; see <u>Figure 3</u>		-	794	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	300	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-c	Irain diode					
I _S	source current	T _{mb} = 25 °C	[3]	-	198	А
			[1]	-	75	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	794	А
Avalanch	ne ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$I_D = 75 \text{ A}; V_{sup} \le 40 \text{ V}; R_{GS} = 50 \Omega; V_{GS} = 5 \text{ V};$ $T_{j(init)} = 25 ^{\circ}\text{C}; \text{ unclamped}$		-	1.6	J

[1] Continuous current is limited by package.

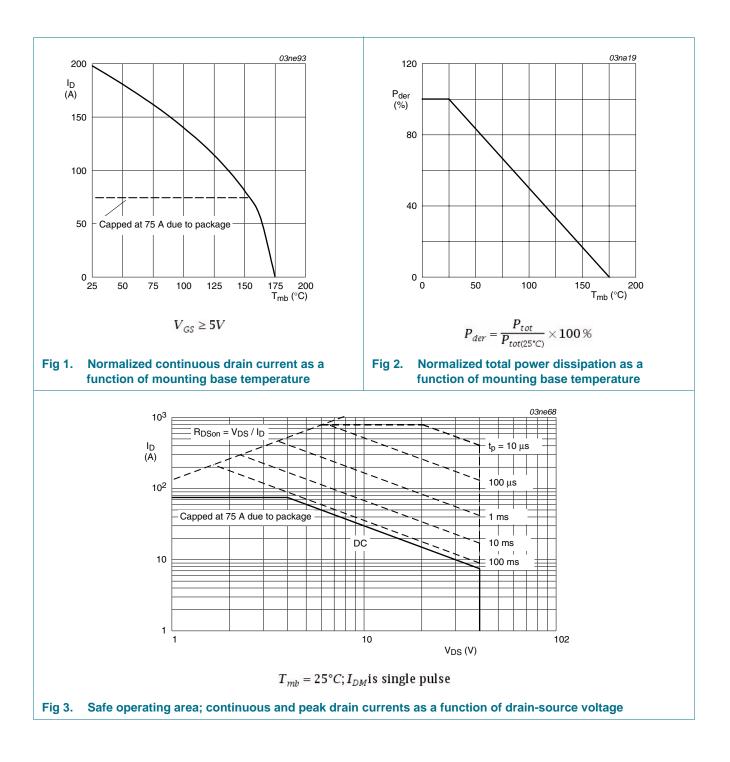
[2] Current is limited by power dissipation chip rating.

[3] Current is limited by power dissipation chip rating

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BUK9504-40A

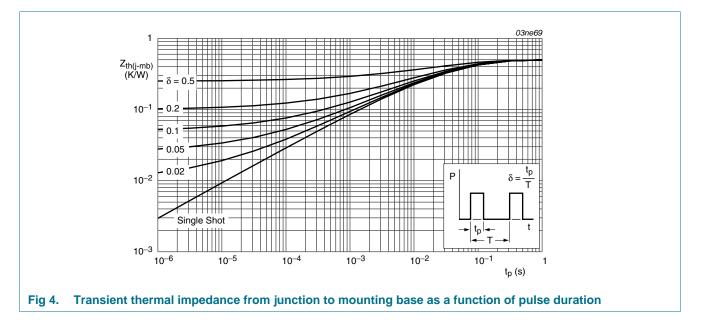
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5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.5	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W



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6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	40	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	36	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 10</u>	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see <u>Figure 10</u>	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 10</u>	-	-	2.3	V
I _{DSS}	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μA
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μA
I _{GSS}	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_{j} = 25 ^{\circ}\text{C}$	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V _{GS} = 4.3 V; I _D = 25 A; T _j = 25 °C	-	3.7	5.9	mΩ
	resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C	-	2.9	4	mΩ
		V _{GS} = 5 V; I _D = 25 A; T _j = 175 °C; see <u>Figure 11</u> ; see <u>Figure 12</u>	-	-	8.3	mΩ
		$V_{GS} = 5 \text{ V}; \text{ I}_D = 25 \text{ A}; \text{ T}_j = 25 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 12</u>	-	3.5	4.4	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 5 \text{ V};$	-	128	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 13</u>	-	13	-	nC
Q _{GD}	gate-drain charge		-	56	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz;	-	6200	8260	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 14$	-	1040	1250	pF
C _{rss}	reverse transfer capacitance		-	680	940	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	62	-	ns
t _r	rise time	R _{G(ext)} = 10 Ω; T _j = 25 °C	-	309	-	ns
t _{d(off)}	turn-off delay time		-	365	-	ns
t _f	fall time		-	306	-	ns
L _D	internal drain inductance	from contact screw on mounting base to centre of die SOT78 ; $T_j = 25 \text{ °C}$	-	3.5	-	nH
		from drain lead 6 mm from package to centre of die ; $T_j = 25 \text{ °C}$	-	4.5	-	nH
L _S	internal source inductance	from source lead to source bond pad ; $T_j = 25 \ ^{\circ}C$	-	7.5	-	nH

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Symbol

Source-drain diode

BUK9504-40A

Max

Unit

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Тур

Min

V _{SD}	source-drain voltage	$I_S = 40 \text{ A}; V_{GS} = 0 \text{ V}$ see <u>Figure 15</u>	; T _j = 25 °C;	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{\rm S} = 20 \text{ A}; \text{ dI}_{\rm S}/\text{dt} = -1$	00 A/µs;	-	260	-	ns
Qr	recovered charge	V _{GS} = -10 V; V _{DS} = 3	$30 \text{ V}; \text{ I}_{\text{j}} = 25 ^{\circ}\text{C}$	-	531	-	nC
Fig 5. ($T_{j} = 25^{\circ}C; t_{p} = 300\mu$	o current as a		6 9 $T_j = 25^{\circ}C;I_D$ urce on-state r ource voltage;	= 25A esistanc		
100 9fs (S) 80 60 40 20		03nd92	100 ^I D (A) 80 60 40 20 0 0 0	T _j = 175 °C	T _j = 25 °C	03nd93	
	$T_j = 25^{\circ}C; V_{DS} = 25$	V		$V_{DS} = 25$	V		
	Forward transconductance a drain current; typical values	as a function of		characteristics of gate-source			

Table 6. Characteristics ...continued

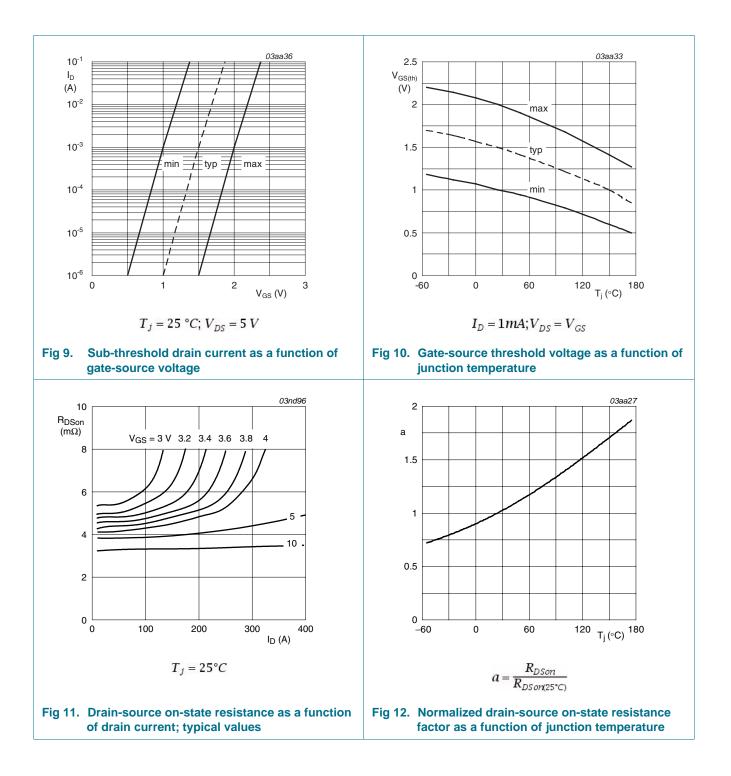
Parameter

Conditions

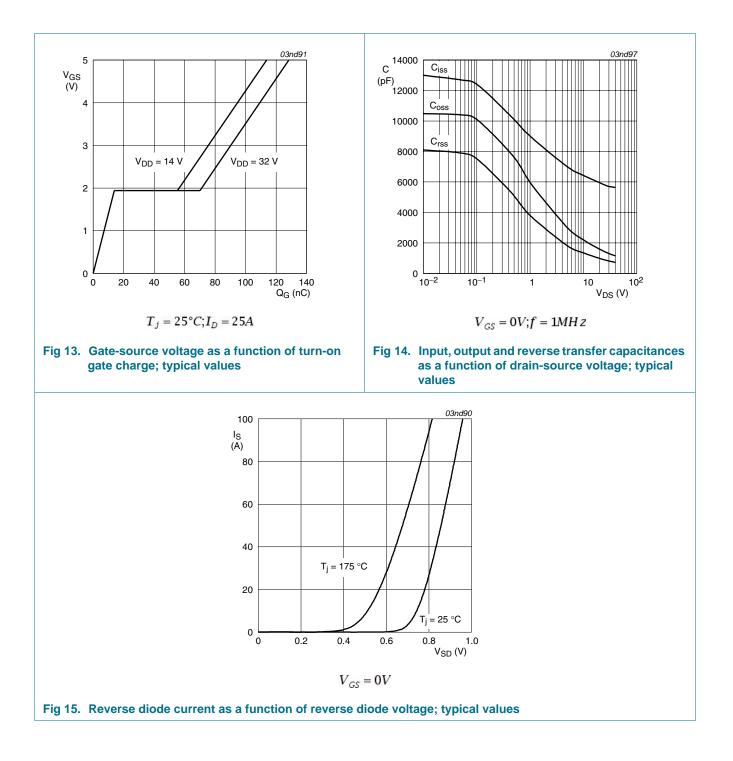
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7. Package outline

				[™]	b₁-►			5 		0 mm			← c			
					ensions)			sca								
IMEN	SIONS (m	nm are th	ne oriair	nal dime			D ₁	Е	е		. (1)	L ₂				-
	SIONS (m					D	D1			-	L1(1)	-2	p	n	Q	
		nm are th A ₁ 1.39	b 0.9	hal dime b ₁ 1.3	c 0.7	D 15.8	6.4	10.3	2.54	L 15.0	L1 ⁽¹⁾ 3.30	-2 max. 3.0	р 3.8	q 3.0	Q 2.6	-

Fig 16. Package outline SOT78A (TO-220AB)

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8. Revision history

Table 7.	Revision history				
Documen	t ID	Release date	Data sheet status	Change notice	Supersedes
BUK9604-	40A v.2	20110207	Product data sheet	-	BUK95_96_9E04_40A-01
Modificatio	ons:		this data sheet has been NXP Semiconductors.	redesigned to comp	ly with the new identity
 Legal texts have been adapted to the new company name where appropriat 				where appropriate.	
		 Type number I 	BUK9604-40A separated	from data sheet BU	K95_96_9E04_40A-01.
BUK95_96	6_9E04_40A-01	20011024	Product specification	-	-

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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